



**CHENMKO ENTERPRISE CO.,LTD**

**SURFACE MOUNT**

**Dual N-Channel Enhancement MOS FET**

VOLTAGE 50 Volts CURRENT 0.51 Ampere

**2N7002DSPT**

Lead free devices

**APPLICATION**

- \* Servo motor control.
- \* Power MOSFET gate drivers.
- \* Other switching applications.

**FEATURE**

- \* Small surface mounting type. (SC-74/SOT-457)
- \* High density cell design for low  $R_{DS(ON)}$ .
- \* Suitable for high packing density.
- \* Rugged and reliable.
- \* High saturation current capability.
- \* Voltage controlled small signal switch.

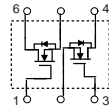
**CONSTRUCTION**

- \* Dual N-Channel Enhancement

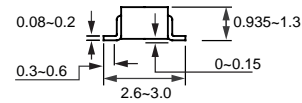
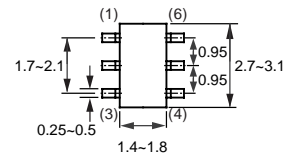
**MARKING**

- \* 72DS

**CIRCUIT**



SC-74/SOT-457



Dimensions in millimeters

SC-74/SOT-457

**Absolute Maximum Ratings**  $T_A = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	2N7002DSPT	Units
$V_{DSS}$	Drain-Source Voltage	50	V
$V_{DGR}$	Drain-Gate Voltage ( $R_{GS} \leq 1\text{ M}\Omega$ )	50	V
$V_{GSS}$	Gate-Source Voltage - Continuous	$\pm 20$	V
$I_D$	Maximum Drain Current - Continuous - Pulsed	$T_A = 25^\circ\text{C}$	510
		$T_A = 70^\circ\text{C}$	1500
$P_D$	Maximum Power Dissipation	$T_A = 25^\circ\text{C}$	960
		$T_A = 70^\circ\text{C}$	900
$T_J, T_{STG}$	Operating and Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$T_L$	Maximum Lead Temperature for Soldering Purposes, 1/16" from Case for 10 Seconds	300	$^\circ\text{C}$

**Thermal characteristics**

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	130	$^\circ\text{C/W}$
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	60	$^\circ\text{C/W}$

2004-7

## RATING CHARACTERISTIC CURVES ( 2N7002DSPT )

**Electrical Characteristics**  $T_A = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Conditions	Min	Typ	Max	Units
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### OFF CHARACTERISTICS

$BV_{DSS}$	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$	50			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 40\text{ V}, V_{GS} = 0\text{ V}$			1	$\mu\text{A}$
		$T_C = 125^\circ\text{C}$			0.5	$\text{mA}$
$I_{GSSF}$	Gate - Body Leakage, Forward	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$			100	$\text{nA}$
$I_{GSSR}$	Gate - Body Leakage, Reverse	$V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$			-100	$\text{nA}$

### ON CHARACTERISTICS (Note 1)

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$	1	1.9	2.5	V
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = 10\text{ V}, I_D = 510\text{ mA}$		1	2	$\Omega$
		$V_{GS} = 4.5\text{ V}, I_D = 350\text{ mA}$		1.6	4.0	
$I_{D(on)}$	On-State Drain Current	$V_{GS} = 10\text{ V}, V_{DS} = 10\text{ V}$	1500			$\text{mA}$
$g_{FS}$	Forward Transconductance	$V_{DS} = 10\text{ V}, I_D = 510\text{ mA}$		400		$\text{mS}$

### DYNAMIC CHARACTERISTICS

$Q_g$	Total Gate Charge	$V_{DS} = 25\text{ V}, V_{GS} = 10\text{ V}, I_D = 510\text{ mA}$		1		$\text{nC}$
$Q_{gs}$	Gate-Source Charge			0.19		
$Q_{gd}$	Gate-Drain Charge			0.33		
$C_{iss}$	Input Capacitance	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}$		20		$\text{pF}$
$C_{oss}$	Output Capacitance			13		
$C_{riss}$	Reverse Transfer Capacitance			5		
$t_{on}$	Turn-On Time	$V_{DD} = 25\text{ V}, I_D = 250\text{ mA}, V_{GS} = 10\text{ V}, R_{GEN} = 25\ \Omega$		6	20	$\text{nS}$
$t_r$				6	20	
$t_{off}$	Turn-Off Time	$V_{DD} = 25\text{ V}, I_D = 250\text{ mA}, V_{GS} = 10\text{ V}, R_{GEN} = 25\ \Omega$		11	20	$\text{nS}$
$t_f$				5	20	

### DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS

$I_S$	Maximum Continuous Drain-Source Diode Forward Current			510	$\text{mA}$	
$I_{SM}$	Maximum Pulsed Drain-Source Diode Forward Current			1.5	A	
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = 200\text{ mA}$ (Note 1)		0.8	1.2	V

Note:

1. Pulse Test: Pulse Width < 300 $\mu\text{s}$ , Duty Cycle < 2.0%.

## RATING CHARACTERISTIC CURVES ( 2N7002DSPT )

### Typical Electrical Characteristics

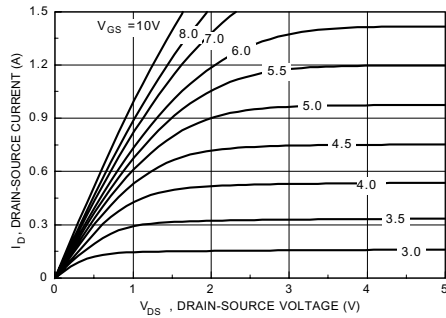


Figure 1. On-Region Characteristics.

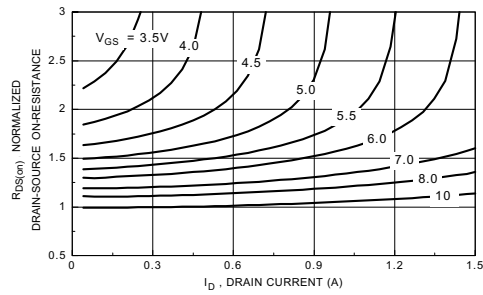


Figure 2. On-Resistance Variation with Gate Voltage and Drain Current.

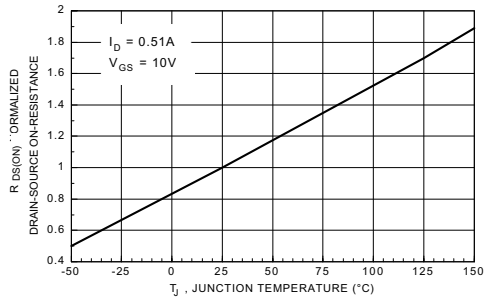


Figure 3. On-Resistance Variation with Temperature.

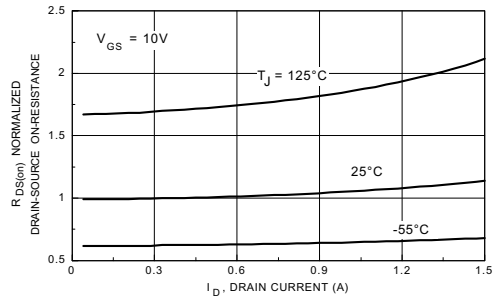


Figure 4. On-Resistance Variation with Drain Current and Temperature.

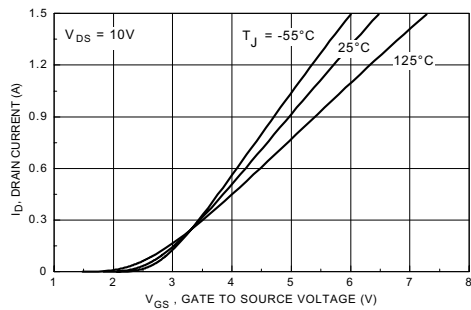


Figure 5. Transfer Characteristics.

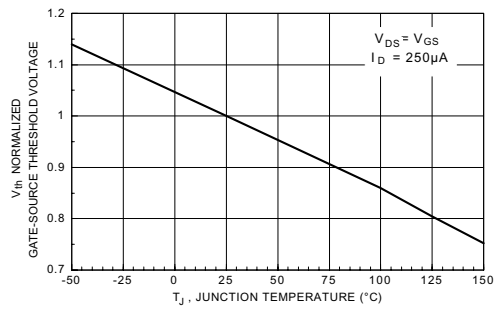
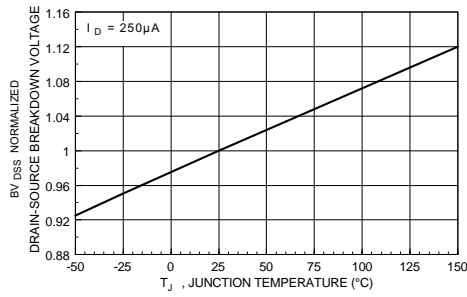


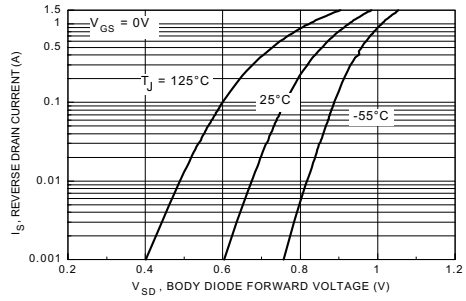
Figure 6. Gate Threshold Variation with Temperature.

## RATING CHARACTERISTIC CURVES ( 2N7002DSPT )

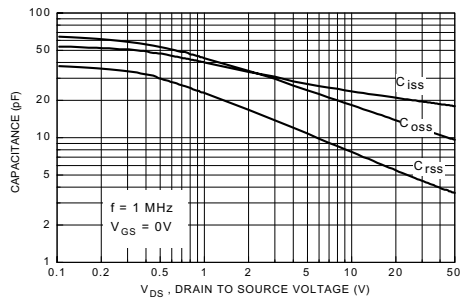
### Typical Electrical Characteristics (continued)



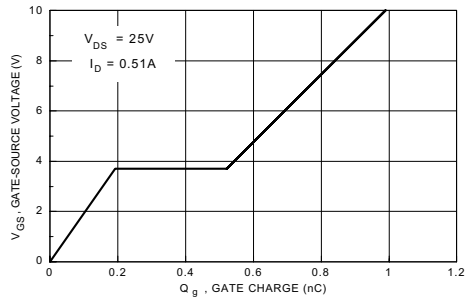
**Figure 7. Breakdown Voltage Variation with Temperature.**



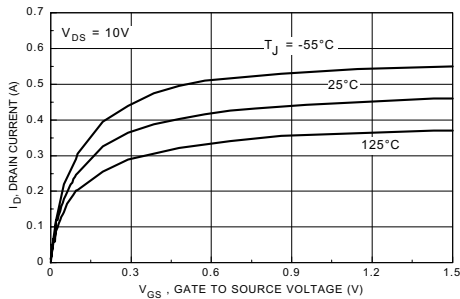
**Figure 8. Body Diode Forward Voltage Variation with Current and Temperature.**



**Figure 9. Capacitance Characteristics.**



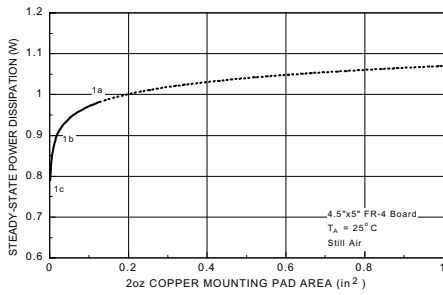
**Figure 10. Gate Charge Characteristics.**



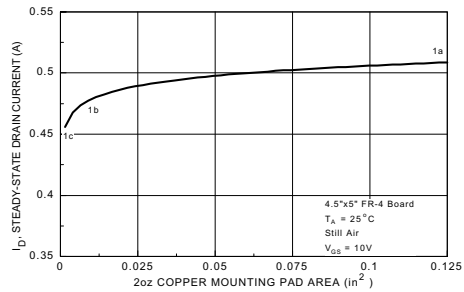
**Figure 11. Transconductance Variation with Drain Current and Temperature.**

## RATING CHARACTERISTIC CURVES ( 2N7002DSPT )

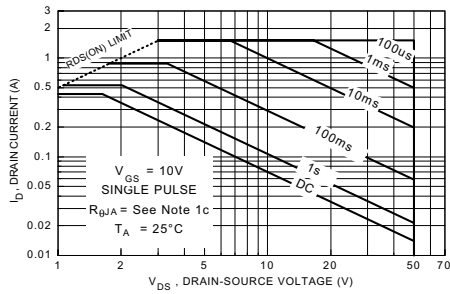
### Typical Thermal Characteristics



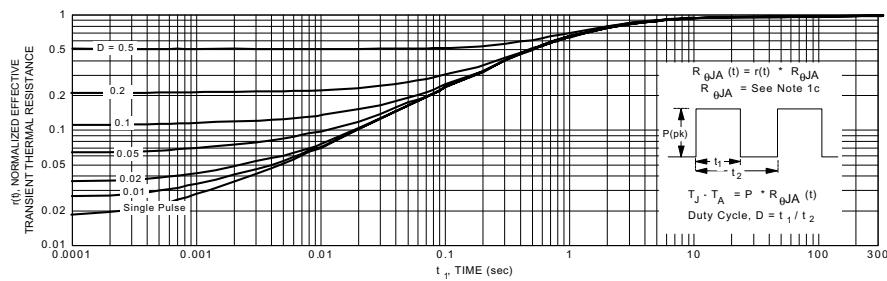
**Figure 12. SOT-6 Dual Package Maximum Steady-State Power Dissipation versus Copper Mounting Pad Area.**



**Figure 13. Maximum Steady-State Drain Current versus Copper Mounting Pad Area.**



**Figure 14. Maximum Safe Operating Area.**



**Figure 15. Transient Thermal Response Curve.**

Note: Thermal characterization performed using the conditions described in note 1c. Transient thermal response will change depending on the circuit board design.